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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/295,329	04/21/1999	YASUMASA KAWABE	Q54114	7050
75	90 10/28/2003		EXAM	INER
MARK BOLAND			THORNTON, YVETTE C	
SUGHRUE MION ZINN MACPEAK & SEAS 2100 PENNSYLVANIA AVENUE N W			ART UNIT	PAPER NUMBER
WASHINGTON	N, DC 200373202		1752	
			DATE MAILED: 10/28/2003	

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)	
	09/295,329	KAWABE ET AL.	
Office Action Summary	Examiner	Art Unit	
	Yvette C. Thornton	1752	
The MAILING DATE of this communication app Period for Reply	pears on the cover sheet w	ith the correspondence address -	
A SHORTENED STATUTORY PERIOD FOR REPL	Y IS SET TO EXPIRE 3 M	IONTH(S) FROM	
THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.1 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a replectified in the provision of the period for reply is specified above, the maximum statutory period of Failure to reply within the set or extended period for reply will, by statute Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b). Status	36(a). In no event, however, may a y within the statutory minimum of thin will apply and will expire SIX (6) MOI , cause the application to become A	reply be timely filed ty (30) days will be considered timely. NTHS from the mailing date of this communica BANDONED (35 U.S.C. § 133).	ation.
1)⊠ Responsive to communication(s) filed on 22 A	August 2003 .		
	is action is non-final.		
3) Since this application is in condition for allows closed in accordance with the practice under Disposition of Claims			ts is
4)⊠ Claim(s) <u>1-26</u> is/are pending in the application			
4a) Of the above claim(s) is/are withdraw			
5)⊠ Claim(s) <u>16-26</u> is/are allowed.			
6)⊠ Claim(s) <u>1-15</u> is/are rejected.	•		
7) Claim(s) is/are objected to.			
8) Claim(s) are subject to restriction and/o	r election requirement.		
Application Papers	·		
9) The specification is objected to by the Examine	r.		
10)☐ The drawing(s) filed on is/are: a)☐ accep	oted or b) objected to by	he Examiner.	
Applicant may not request that any objection to the	e drawing(s) be held in abey	ance. See 37 CFR 1.85(a).	
11)☐ The proposed drawing correction filed on	_ is: a)□ approved b)□ o	disapproved by the Examiner.	
If approved, corrected drawings are required in rep	•		
12) The oath or declaration is objected to by the Ex	aminer.		
Priority under 35 U.S.C. §§ 119 and 120			
13) Acknowledgment is made of a claim for foreign	priority under 35 U.S.C.	§ 119(a)-(d) or (f).	
a)⊠ All b)□ Some * c)□ None of:			•
1. Certified copies of the priority documents	s have been received.		
2. Certified copies of the priority document	s have been received in A	Application No	
 3. Copies of the certified copies of the prior application from the International Bu * See the attached detailed Office action for a list 	reau (PCT Rule 17.2(a)).		
14) Acknowledgment is made of a claim for domesti	c priority under 35 U.S.C.	§ 119(e) (to a provisional applic	ation).
a) ☐ The translation of the foreign language pro			
Attachment(s)			
1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449) Paper No(s)	5) Notice of	Summary (PTO-413) Paper No(s) Informal Patent Application (PTO-152)	- :

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DETAILED ACTION

This is written in reference to application number 09/295,329 filed on April 21, 1999; CPA filed on September 9, 2000; and RCE filed on February 10, 2003.

Response to Amendment

1. Claims 1-26 are currently pending.

Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. Claims 1-15 are rejected under 35 U.S.C. 103(a) as being unpatentable over Suwa (EP 789,278). Suwa teaches a radiation sensitive resin composition comprising a resin containing an alicyclic skeleton in its backbone (A), and acid generating agent (B), an acid cleavable additive, a nitrogen containing basic compound and additives such as surface active agents. The said resin A may contain at least one group, which is cleaved by an acid at any position thereon. The alicyclic skeleton may optionally contain one or more substituents. The said resin is preferably a resin, which becomes alkali soluble due to catalytic action of an acid to cleave the acid cleavable groups. Preferred alicyclic skeletons are given by the general formula (2) (page 3, 1. 20-15, 1. 57). The taught acid generating agent can selected from the group consisting of onium salts, halogen containing compounds, diazoketone compounds, sulfone compounds and sulfonic acid compounds (pg. 16, l. 1-pg. 17, l. 3). The said acid generators

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can be used singly or in combination of two or more. The acid generator is present in the amount of 0.1-10 pbw per 100 pbw of the resin (pg. 17, l. 4-9). Suwa teaches that the addition of an acid cleavable additive serves to improve contrast as a positive type photoresist and increase affinity of the resin for an alkaline developing solution. The said additive includes polymeric compounds or low molecular weight compounds having at least one acid cleavable group (pg. 17, l. 10-15). Specific examples include t-butyl adamantane carboxylate, cholic acid t-butyl ester, etc. (pg. 17, l. 58-pg. 18, l. 9). The addition of a compound, which acts as a Lewis base to an acid generated from the acid generating agent, improves perpendicularity of the side walls formed by a positive working resist system. Specific examples of such compounds include tri-n-butylamine, triethanolamine and 2methylpryridine (pg. 18, l. 15-28). A variety of other additives can optionally be added to the resin composition. These additives include surface active agents such as FLUORAD FC430, FC431, SURFLON S-382, SC-101 and the like (pg. 18, l. 36-44). It is the examiner's position the taught FLUORAD compounds meet the limitation of a fluorine containing surfactant and the SURFLON compounds meet the limitation of a silicon containing surfactant. The said additives can be used singly or as a mixture of two or more. The composition solution is prepared by dissolving the taught components in a solvent. Suitable solvents include propylene glycol monoethyl ether acetate, 2-heptanone, methyl 3methoxypropionate and ethyl 3-ethoxypropionate, ethylene carbonate, propylene carbonate and so forth (pg. 19, l. 5-26). The solvents can be used in singly or in a mixture of two or more. A variety of radiation types can be used to expose the resist composition. Examples include far UV radiation such as KrF and ArF (pg. 19, l. 30-37). In example 5, Suwa

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exemplifies a resin composition comprising resin AIII-4 (pg. 25, 1. 25-pg. 26, 1. 25), 4-hydroxynaphthyldimethylsulfonium triflate as an acid generating agent, tri-n-butylamine as the acid cleavable additive, and a solvent mixture of ethyl 2-hydroxypropionate and 2-heptanone (pg. 42, 1. 35-pg. 43, 1. 25; Table 2). It is the examiner's position that the exemplified acid generator meets the limitation of an onium salt and the said acid cleavable additive meets the limitation of a low molecular acid decomposable compound as claimed by the applicant. One of ordinary skill in the art would have been motivated by the teachings of Suwa to include either a single or a combination of two or more surface active agents into the exemplified composition of example 5 in order to improve the coating properties. Although a solvent mixture of three components is not exemplified one of ordinary skill in the art would have been enabled by the teachings of Suwa to use two or more of the disclosed solvents to prepare the taught composition.

Response to Arguments

4. Applicant's arguments filed August 22, 2003 have been fully considered but they are not persuasive. The examiner has re-considered the comparative data presented in the declaration submitted on April 4, 2003. Applicants evaluate comparative data by two distinct parameters: (1) residual film rate and (2) profile. The numbers presented in the inventive examples for residual film rate are 99.3% and 99.6%. The numbers presented for the comparative examples are 94.6% and 95.2%. Applicants argue that the difference in the inventive examples and the comparative examples presents an extremely large difference in the art and is considered to be an unexpected result to one of ordinary skill in the art. The applicant however has provided no evidence that such a difference is indeed substantial. In

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re Klosak (173 USPQ 14) has established that, "it is not enough to show that results are obtained which differ from those obtained in the prior art: that difference must be shown to be an unexpected difference." See also In re Freeman (177 USPQ 139). Applicants merely state on the record that the results are unexpected. Applicants attempt to show that the differences of 0.3 and 0.6 are indeed significant to one of ordinary skill in the art by submitting the prior art reference US 4,719,167. The said reference exemplifies that 2% difference in fractional film thickness. In response to the examiner statement that there was no correlation which would indicate that a 2% difference in fractional film thickness as evaluated by the prior art is related to residual film rate as claimed by the present invnetion, Applicants provide an explanation pertaining to the relationship between the residual film rate and the fractional film thickness. While the applicants has established a clear relationship, there is no evidence which shows that the difference in residual rates for the inventive examples and the comparable examples is substantial and unexpected to one of ordinary skill. Therefore, the said reference can not be relied upon to show that the differences in the declaration data is significant and therefore unexpected.

5. In regard to profile, applicants provide two definitions. Profile A, which is a rectangular pattern, and profile B, which is anything other than rectangular. Applicants further define profile A to have an angle of 85-90 between the substrate and the sidewall, wherein 88-89 is particularly preferred. Profile B has an angle of 80-85. The angles presented for the inventive examples are 89 and 88. The angles presented for the comparative examples are 85 and 85. The examiner is unclear as to why the comparative examples are labeled as profile B, when the angles are clearly within the range of profile A.

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In response, the attorney attempts to clarify the definitions of Profile A and B as set forth in the declaration submitted by inventor Yasumasa Kawabe. The remarks state that the textual description of the definition of profile A contained a clerical error. The examiner is of the position that the definitions of the said profiles are provided in a signed declaration which states that the all the statements are true. Therefore if the definition is to be re-defined, the change must be presented in a signed declaration.

6. The examiner maintains the position that the declaration evidence of record fails to show unexpected results. The examiner suggest submitting photographs of both the inventive examples and the comparative examples.

Allowable Subject Matter

- 7. Claims 16-26 are allowed.
- 8. The following is an examiner's statement of reasons for allowance: The comparative data II (Table B and B') were successful in showing unexpected and superior results upon using a solvent mixture within the limitations of instant claims 16-22 as compared to the prior art.
- 9. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

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Conclusion

10. THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

- 11. A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.
- 12. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Yvette C. Thornton whose telephone number is 703-305-0589. The examiner can normally be reached on Monday-Thursday 8-6:30.
- 13. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Janet C. Baxter can be reached on 703-308-2303. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.
- 14. Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-1495.

yct October 22, 2003 SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 1700